सी एस आई आर-राष्ट्रीय पर्यावरण अभियांत्रिकी अनुसंधान संस्थान



CSIR- National Environmental Engineering Research Institute नेहरु मार्ग, नागपुर ४४००२०, भारत Nehru Marg, Nagpur – 440 020 (M.S.), India



टेलीफ़ोन Telephone 0712-2249992, 2249746, 2226705 ईमेल Email:- <u>spo@neeri.res.in</u>, <u>st_pur@neeri.res.in</u>

वैबसाइटWebsite: www.neeri.res.in

शीर्षक: Supply, Installation and Commissioning of (1) Triple Quadrupole Gas Chromatography Mass

Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass

Spectrometry with Electron Impact and Chemical Ionization के लिए ईओआई एवं मांगपत्र पूर्व सम्मेलन.

TITLE: Expression of Interest and pre-indent conference for Supply, Installation and Commissioning of (1) Triple Quadrupole Gas Chromatography Mass Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass Spectrometry with Electron Impact and Chemical Ionization

Supply, Installation and Commissioning of (1) Triple Quadrupole Gas Chromatography Mass Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass Spectrometry with Electron Impact and Chemical Ionization उपकरण आपूर्ति के लिए, यह संस्थान एक्स्प्रेशन ऑफ इंटरेस्ट आमंत्रित करता है।

This Institute invites Expression of Interest (EOI) for Supply, Installation and Commissioning of (1) Triple Quadrupole Gas Chromatography Mass Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass Spectrometry with Electron Impact and Chemical Ionization.

एक्स्प्रेशन ऑफ इंटरेस्ट दिनांक	तक इस संस्थान में प	मह्ँच जाना चाहिए। र	,ाष्ट्रिय पर्यावरण अ	भियांत्रिकी अनुसंधान
संस्थान, नेहरू मार्ग, नागपुर-440020 के समिति कक्ष में दि	ज्ञांक <u> </u>	सुबह बजे ब	माँगपूर्व संमेलन अ	ायोजित किया गया है।
The EOI must reach this Institute latest by o	date <mark>27.01.2025</mark> .	A Pre-indent C	onference has	been scheduled
to be held at <mark>11.00 am</mark> on <u>30.01.202</u>	5 in the Comm	ittee Room o	of National	Environmental
Engineering Research Institute, Nehru	Marg, Nagpur-44	10 020. INDIA		

ईच्छुक पार्टियां अपने उत्पाद / मॉडल के तकनीकी प्रस्तुतीकरण तथा उसकी उपयोगिता, प्रौद्योगिकी, सुविधा, साहित्य, डिज़ाइन, तकनीकी पैरामीटर, ग्राहकी तथा अन्य संबिधत मुद्दों पर तकनीकी समिति से चर्चा करने के लिए तकनीकी रूप से सक्षम प्रतिनिधि नियुक्त कर सकते है। तकनीकी समिति मांग पूर्व संमेलन में भाग लेने वाले कंपनी / विक्रेताओं के क्रेडेंशियल्स / तकनीकी क्षमताओं / वितीय स्थिति का मुल्यांकन करेगी।

Interested parties may depute their competent technical representatives to make presentation of their product/ model(s) and discuss with the Technical Committee on the aspects of utility, technology, feature, literature, design, technical parameters, clientele and other related issues of the equipment. The Technical Committee shall also evaluate the credentials/ technical capabilities/ financial standings with track record of the companies/ vendors attending PIC.

Process of EOI and PIC:

Last date of submission of EOI: 27.01.2025 .

PIC : on 30.01.2025, Time 11.00 AM

- 1) OEM/Suppliers/ Agent must:
- a) Send Expression of Interest to participate in pre-indent Conference latest by date 27.01.2025 through e-mail.
 - i) Send Printed technical Literature duly indicating point to point NEERI requirement and offered point to point technical compliance, as per Annexure-III.
- **2)** Attend Pre-Indent Conference by fully Technical Competent personnel on : **30.01.2025** to present before CSIR-NEERI Technical Committee:
 - i) Specific Model and make: meeting CSIR-NEERI technical specifications.
 - ii) One printed copy of Supporting Technical Literature.
- 3) Tentative Technical Specification are as per Annexure I
- 4) Qualification requirement are as per Annexure-II

मांग पूर्व संमेलन में भाग लेने के लिए तकनीकी रूप से सक्षम प्रतिनिधि को अधिकृत किया जाना चाहिए जो जगह पर निर्णय ले सकें तथा सिमित द्वारा उठाए गए बिन्दुओं की पुष्टि कर सकें। तकनीकी प्रतिनिधि नीरी तकनीकी सिमिति द्वारा अंतिम रूप दिये गए तकनीकी विनिर्देशों पर हस्ताक्षर करने के लिए सक्षम होना चाहिए। Technically competent representative should be authorized for attending Pre-Indent Conference who can take on the spot decision and confirm on the points raised by Technical Committee. Technical representative should be able to sign the final technical specifications finalized by the NEERI Technical Committee.

Kindly note that post EOI & PIC, OTE/GTE shall be floated under two bid system and participation in the same shall not be restricted to participated bidders of EOI.

Interested parties may submit EOI regarding Supply, Installation and Commissioning of (1)

Triple Quadrupole Gas Chromatography Mass Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass Spectrometry with Electron Impact and Chemical Ionization, addressed to the Director, CSIR-NEERI, Nehru Marg, Nagpur- 440 020 by email on st-pur@neeri.res.in, spo@neeri.res.in, <a h

<u>भंडार एवं क्रय अधिकारी /Stores & Purchase Officer</u> CSIR-NEERI, Nagpur

Tentative Specifications / requirement (Annexure- I)

Supply, Installation and Commissioning of (1) Triple Quadrupole Gas Chromatography Mass Spectrometry with Thermal Desorber and (2) Triple Quadrupole Gas Chromatography Mass Spectrometry with Electron Impact and Chemical Ionization

Tentative Technical Specifications for Gas Chromatograph-Mass Spectrometer

System 1: Gas Chromatograph Triple Quadrupole Mass Spectrometer with Electron Ionization

with Thermal Desorber.

SI. No	Requirement	Description
Gas C	hromatography: GC with autom	ated flow & Pressure Electronic /Pneumatic controlled for injector and detector
		tectors. GC Graphical User Interface (GUI)
1	Column Oven	 Accommodate two capillary columns Temp. Range: Ambient +4 to 450°C Ramp rate: maximum 120°C/min or more Cooling rate: 450°C to 50°C in less than 4 min Typical Retention Time Repeatability: <0.008 min or better Number of Ramps/Plateaus: 20/21 or more
2	Injector port – 1 No.	Split/split less capillary injector should be able to operate with capillary, wide bore column. Maximum temperature: 400 °C Split ratio 7500:1 or more Purge flow from 0 to 50 mL/min
3	Auto Sampler	 Automated liquid sampler with 100 Vials capacity Syringes Size: 5 μL, 10 μL Compatible with standard, gas-tight and plunger in-needle syringes
4	Thermal Desorber	 A thermal desorption assembly from a reputed OEM to be quoted and hyphenated with the quoted GC-Triple Quadrupole system for environmental applications. It should be fully automated thermal desorption system for the rapid and unattended processing of up to 100 sample sorbent tubes in a single sequence. Trap heating rates up to 100°C/s Primary tube desorption oven temperature range should be in the range 35°C to 425°C with settable in 1°C increments and user settable within the stated range. Trap low temperature in the range: -30°C to 50°C, settable in 1°C increments. Trap desorption - 100°C/s, also programmable rates from 1°C/s to 40°C/s to be available. 100 Qty. of tubes for environmental applications to be included. Auto-low flow TD sampling pump to be quoted. Tube conditioner for TD tube conditioning should also be included Tube Desorption Flow Rate- Settings: 20 mL/min to 200 mL/min (1 mL/min increments; Accuracy ±2 mL/min) Transfer Line Temperature Settings: 0 °C to 350 °C (1 °C increments)
Triple	Quadruple Mass Spectrometer w	ith Electron Ionization Source
5	Electron Impact Ionization	 Ion Source temperature: up to 350°C Electron energy range up to 150 eV or better Ionization modes: EI & System should have dual filament with automatic filament switching. EI Scan sensitivity: 2000:1 for 1pg of OFN for the mass m/z 272 using 30 m column
6	Triple Quadrupole Analyzer	 Mass Range: 10 to 1000 amu or better. The collision energy must be adjustable in the range of 1 – 60 eV in user-programmable increments of 1 eV.

SI. No	Requirement	Description
ATES	not nectually tales rate in	The collision cell must support minimum SRM dwell time of 500 μs.
		Mass axis stability: ±0.1 amu over 48 hours
		Mass resolution: 0.4 to 3.0 amu (FWHM)
		MRM/SRM speed: 800 transition / second.
	rigition	Dwell time: < 0.5 msec
		Scan rate: 20000 amu/second (Q3 Scan)
	controlled for Injector and debi	The instrument control must have the ability to alternate between Full
		Scan MS and SRM/SIM target analysis on successive scans
		The instrument control must support the following scan modes:
		1. MS Mode: full scan (FS), SIM and FS/SIM simultaneous within
		single sample injection,
	nim è	2. MS/MS Mode: full scan (FS), SRM and FS/SRM simultaneou
	0.000 min or bistor	within a single sample injection
2000	1 500	Instrument Detection Limit : IDL ≤ 0.3 fg OFN
7	Detector	Detector with off-axis, discrete dynode electron multiplier
		• linear range of >10 ⁷
8	Vacuum pump:	Dual inlet turbo molecular pump with capacity of 300 L/sec or better.
9	Database and software	NIST 2023 library with license, Library data base in digital storage media
	y305000 d	Compatible license software for instrument control and data analysis for
		qualitative & quantitative workflow
10	Computer & Printer	 Compatible latest PC with i7 processor or equivalent with 1 TB hard dis and 8 GB RAM and 24' TFT monitor with color printer
11	Consumables	ο 10 μl SYR Bevel Tip -10 Nos
	Triple fluadripoli system	ο 5 μl SYR Bevel Tip -10 Nos
		o Filament for MS - 10 Nos.
	description system for the rapid	o Liner for Split/Splitless Pk of 5 -5 Nos
	sample terbent tuber in a s	o Column nut, SSL Pk of 10 -10 Nos
		OIL, vacuum pump, 1 liter -3Nos
		o MS performance spec kit -1 Set
3	many categories and the or	 Vespel Ferrule capillary nut 0.1-0.25 Pk of 10 -10 Nos each
	fiding aids that the straight	 Vespel Ferrule capillary nut 0.32 Pkof 10 -01 Nos
		○ Septa BTO PK of 50 − 10 Nos
	in bidation 200 of 300	○ Ion source cleaning compound − 1 pack
		○ Cleaning paper – 10 Nos.
	1764 at 1/21 ment rates authinin	o 1000 qty autosampler vials with caps
		o Tool Kit for GC & MS
	phosphore on a capable	o Wall mount Gas purification and control system for gases with ga
	channo	regulators
	peprilam equale phone au	Column: DB 5 MS UI - 30 mtr, 0.25 mm ID, 1µm FT or equivalent – 01 No.
	um 1) miniture 90% of similar 0	DB 624 MS UI - 30 mtr, 0.25 mm ID, 1µm FT or equivalent – 01 No
		DB WAX - 30 mtr, 0.25 mm ID, 1µm FT or equivalent – 01 No.
12	Supply requirement	230 V AC ± 5 V AC, 50 Hz
13	Warranty	1 year standard + 2 Year extended warranty for instrument should be provided from yearder.
14	Training & Demonstration	provided from vendor
14	Training & Demonstration	 Vendor should have an application support center in India in case of any demonstration is required vendor should be able to demonstrate the system in India.

System 2: Gas Chromatograph Triple Quadrupole Mass Spectrometer with Electron Ionization and Chemical Ionization.

SI. No	Requirement	Description
		mated flow & Pressure Electronic /Pneumatic controlled for injector and detecto etectors. GC Graphical User Interface (GUI)
1	Column Oven	 Accommodate two capillary columns Temp. Range: Ambient +4 to 450°C Ramp rate: maximum 120°C/min or more Cooling rate: 450°C to 50°C in less than 4 min Typical Retention Time Repeatability: <0.008 min or better Number of Ramps/Plateaus: 20/21 or more
2	Injector port – 1 No.	Split/split less capillary injector should be able to operate with capillary, wide bord column Maximum temperature: 400 °C Split ratio 7500:1 or more Purge flow from 0 to 50 mL/min
3	Auto Sampler	 Automated liquid sampler with 100 Vials capacity Syringes Size : 5 μL, 10 μL Compatible with standard, gas-tight and plunger in-needle syringes
riple (Quadruple Mass Spectrometer	with Electron Ionization Source & Chemical Ionization Source
, 4	Electron Impact Ionization	 Ion Source temperature: up to 350°C Electron energy range up to 150 eV or better Ionization modes: EI & System should have dual filament with automati filament switching. EI Scan sensitivity: 2000:1 for 1pg of OFN for the mass m/z 272 using 30 m column
5	Chemical Ionization	Instrument detection limit < 2 fg Mode: Positive Chemical Ionization (PCI) & Negative Chemical Ionization (NCI) S/N ration: In PCI – 2500:1, In NCI – 10000:1
6	Triple Quadrupole Analyzer	 Mass Range: 10 to 1000 amu or better. The collision energy must be adjustable in the range of 1 – 60 eV in user programmable increments of 1 eV. The collision cell must support minimum SRM dwell time of 500 μs. Mass axis stability: ±0.1 amu over 48 hours Mass resolution: 0.4 to 3.0 amu (FWHM) MRM/SRM speed: 800 transition / second. Dwell time: < 0.5 msec Scan rate: 20000 amu/second (Q3 Scan) The instrument control must have the ability to alternate between Full Sca

SI. No	Requirement	Description
	not)	 The instrument control must support the following scan modes: MS Mode: full scan (FS), SIM and FS/SIM simultaneous within a sing sample injection, MS/MS Mode: full scan (FS), SRM and FS/SRM simultaneous within single sample injection Instrument Detection Limit: IDL ≤ 0.3 fg OFN
7	Detector	 Detector with off-axis, discrete dynode electron multiplier linear range of >10⁷
8	Vacuum pump:	Dual inlet turbo molecular pump with capacity of 300 L/sec or better.
9	Database and software	 NIST 2023 library with license, Library data base in digital storage media Compatible license software for instrument control and data analysis for qualitative & quantitative workflow
10	Computer & Printer	Compatible latest PC with i7 processor or equivalent with 1 TB hard disk and GB RAM and 24' TFT monitor with color printer
, ,	Consumables	 10 μl SYR Bevel Tip -10 Nos 5 μl SYR Bevel Tip -10 Nos Filament for MS - 10 Nos. Liner for Split/Splitless Pk of 5 -5 Nos Column nut, SSL Pk of 10 -10 Nos OlL, vacuum pump, 1 liter -3Nos MS performance spec kit -1 Set Vespel Ferrule capillary nut 0.1-0.25 Pk of 10 -10 Nos each Vespel Ferrule capillary nut 0.32 Pkof 10 -01 Nos Septa BTO PK of 50 - 10 Nos Ion source cleaning compound - 1 pack Cleaning paper - 10 Nos. 1000 qty autosampler vials with caps Tool Kit for GC & MS
		 Wall mount Gas purification and control system for gases with gas regulators Column: DB 5 MS UI - 30 mtr, 0.25 mm ID, 1μm FT or equivalent – 01 No DB 5 MS UI - 60 mtr, 0.25 mm ID, 1μm FT or equivalent – 01 No DB WAX - 30 mtr, 0.25 mm ID, 1μm FT or equivalent – 01 No.
12	Supply requirement	230 V AC ± 5 V AC, 50 Hz
13	Warranty	1 year standard + 2 Year extended warranty for instrument should be provided from vendor
14	Training & Demonstration	 Vendor should have an application support center in India in case of an demonstration is required vendor should be able to demonstrate the system i India.

Annexure – II Qualification Requirement

Pre-Qualification & Eligibility Criteria

Sr. No.	Qualification requirement	Documents required	Complied / Agreed Submitted Document
1.	Vendors / supplier / manufacture / Indian agent should not be debarred /black listed by any government organization / GeM for any product for the past three years. If the same is detected at any stage the contract will be terminated.	Undertaking to be submitted on company letter head separately	TO TOWN TOWN TO THE TOWN TO THE TOWN TOWN TOWN TOWN TOWN TOWN TOWN TOWN
2.	Performance certificate or installation report and purchase order of 02 users from government organization or State government or Central University or PSU for the past two years.	Copies of the Minimum 02 Certificates and Minimum 02 Purchase orders	Pricing \$64-609 mouth instruments redmark lawors in \$55-46 enulasion documents concerns and the second seco
3.	Installation, Operational and Performance qualification (IQ/OQ/PQ) must be performed at site CSIR-NEERI Nagpur	Undertaking to be submitted on company letter head separately	
4.	Bidder must Quote latest model complying the technical specification mentioned in chapter 4	Undertaking to be submitted on company letter head separately	
5.	Vendors should have their application lab in India	Undertaking to be submitted on company letter head separately	
6.	Vendors should have their application note on public domain and on their web site		

Agreed & Submitted with Seal & Sign:-	
---------------------------------------	--

Annexure - III

तकनीकी विनिर्देश अनुपालन एवं विचलन प्रपत्र

Technical Specification Compliance cum Deviation Form

नीरी निविदा सं के अनुसार तकनीकी अनुपालन / Technical Compliance against NEERI Tender No.

Sr. No. NEERI's Vendor In case of Deviations to Reasons Special Technical Quoted Compliance, Remarks if NEERI for **Specifications** Specification supporting deviations specifications any, printed if any, technical literature mentioning page no. Column & line has also to be highlighted 2. 3. 7. 1. 5. 6.

स्थान /	Place:
---------	--------

तारीख / Date:

निर्माता / बोलीदाता के हस्ताक्षर एवं सील

Signature and Seal of the Manufacturer/Bidder